

<b>Notice of References Cited</b>	Application/Control No. <b>09/436,656</b>	Applicant(s)/Patent Under Reexam <b>Tagawa et al.</b>	
	Examiner <b>O'Connor</b>	Art Unit <b>3627</b>	Page 1 of 1

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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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